The Institute for Interconnecting and Packaging Electronic Circuits 2215 Sanders Road • Northbrook, IL 60062



## IPC-TM-650 TEST METHODS MANUAL

- **1 Scope** The purpose of this test method is to provide a procedure to determine the dielectric constant at 1 MHz of laminate or substrate material.
- 2 Applicable Documents None
- 3 Test Specimen
- **3.1** Each specimen shall be 10 cm x 10 cm by the thickness of the laminate or substrate material. Remove copper foil from both sides by etching using standard commercial practices. At least three specimens are required.

## 4 Equipment/Apparatus

- **4.1** A standard capacitance bridge, generator, null detector, and accessories
- 5 Procedure
- **5.1** Preparation
- **5.1.1** Remove foil from both sides of specimens using standard copper etching practices. Rinse in tap water until clean.
- **5.1.2** Condition specimens in distilled water for 24 hours at 23°C, then air dry.
- **5.1.3** Coat both sides of the specimens with silver conductive paint, dry, and file all edges to prevent a conductive path.
- **5.1.4** Calibrate the capacitance bridge assembly.
- **5.1.5** Set the Method dial on "Substitute" and connect the balancing capacitor to the unknown direct terminals.
- **5.1.6** The balancing capacitor must be 100 picofarads greater than the test specimen.

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**5.1.7** Turn the Method switch to the "Substitute" position.

## 5.2 Test

- **5.2.1** Set the Voltage dial for maximum output and obtain a null on the detector by balancing the Capacitance and Dissipation dials, then take the reading of the capacitance of the dissipation.
- **5.2.2** Proceed by connecting the test specimen to the unknown substitute terminals.
- **5.2.3** Obtain a null on the detector by balancing the capacitance bridge, then read the capacitance and the dissipation factor as before.
- **5.3 Calculation** The dielectric constant is computed by using the following equation:

$$K = \frac{4.45t (C_1 - C)}{A}$$

where:

t = thickness of specimen

A = area of specimen

 $C_1$  = capacitance of balancing capacitor

C = capacitance of test specimen

- **5.4 Report** The results should be recorded in a written report, which contains the following as a minimum:
- Certification that the test was performed in accordance with this test method
- · Identification of specimens tested
- The dielectric constant of each specimen tested and the average of the specimens tested for each material
- **6 Notes** The dielectric constant is defined as the ratio of the capacitance with the test material between the two plates to the capacitance of air between the two plates.